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| FORM PTO-1449 US DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE | | Any. Docket No. 83330WRZ Customer No. 01333 | | Serial No. 10/861507 | |
| If AFTER the later date of the first Office Action or 3 months from filing, use only with Rule 97(E) Certificate or Fee LIST OF ART CITED BY APPLICANT <i>(Use several sheets if necessary)</i> | | Applicant: James M. Chwalek, et al | | | |
| | | Filing Date | | Group | |

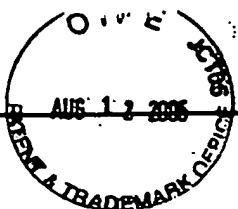
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| EXAMINER | DATE CONSIDERED 4/21/00 |
| *EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. | |

FORM EKC-1449


 Atty. Docket No.
83330WRZ
 Customer No. 01333

 Serial No.
10/824,507

If AFTER the later date of the first Office Action or 3 months from filing, use only with Rule 97(E) Certificate or Fee

 Applicant:
James M. Chwalek, et al
INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(Use several sheets if necessary)

 Filing Date
14 April 2004

 Group
2861
U.S. PATENT DOCUMENTS

| Examiner Initial* | DOCUMENT NUMBER | DATE | NAME | CLASS | SUBCLASS | FILING DATE IF APPROPRIATE |
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| Examiner Initial* | DOCUMENT NUMBER | DATE | COUNTRY | CLASS | SUBCLASS | TRANSLATION | |
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| | | | | | | YES | NO |
| <i>Wm</i> | EP 1 219 425 | 07-03-2002 | EUROPE | 1 | 1 | | X |
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| EXAMINER <i>Lawrence</i> | DATE CONSIDERED <i>4/21/06</i> |
|--------------------------|--------------------------------|

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